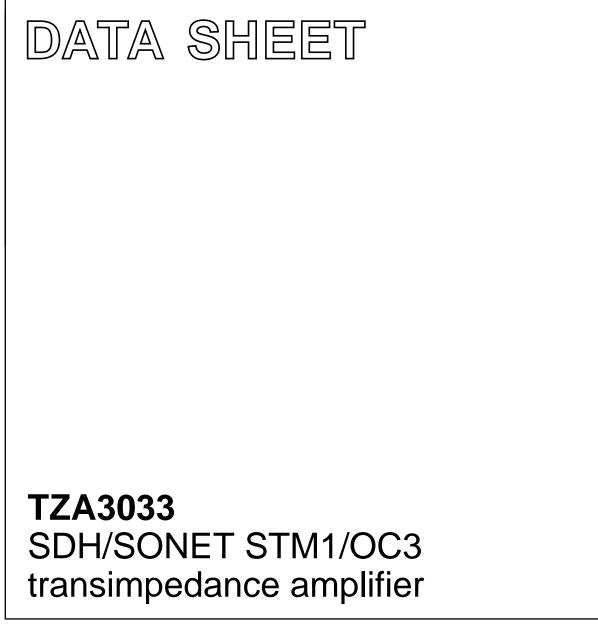
## INTEGRATED CIRCUITS



Objective specification File under Integrated Circuits, IC19



### TZA3033

#### FEATURES

- Low equivalent input noise, typically 1 pA/\/Hz
- Wide dynamic range, typically 0.25  $\mu$ A to 1.6 mA
- Differential transimpedance of 117  $k\Omega$
- Bandwidth minimum 150 MHz
- Differential outputs
- On-chip AGC (Automatic Gain Control)
- No external components required
- Single supply voltage from 3.0 to 5.5 V
- · Bias voltage for PIN diode
- Pin compatible with SA5223.

#### **APPLICATIONS**

- Digital fibre optic receiver in short, medium and long haul optical telecommunications transmission systems or in high speed data networks
- Wideband RF gain block.

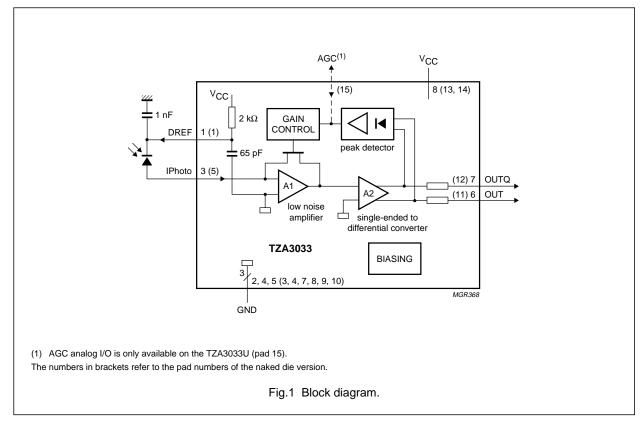
### **GENERAL DESCRIPTION**

The TZA3033 is a low-noise transimpedance amplifier with AGC designed to be used in STM1/OC3 fibre optic links. It amplifies the current generated by a photo detector (PIN diode or avalanche photodiode) and converts it to a differential output voltage.

#### ORDERING INFORMATION

TYPE PACKAGE		PACKAGE	
NUMBER	NAME DESCRIPTION VERSION		VERSION
TZA3033T	SO8	plastic small outline package; 8 leads; body width 3.9 mm St	
TZA3033U	naked die	die in waffle pack carriers; die dimensions $0.960 \times 1.210$ mm	_

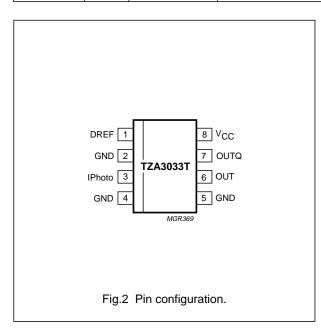
#### **BLOCK DIAGRAM**



### TZA3033

### PINNING

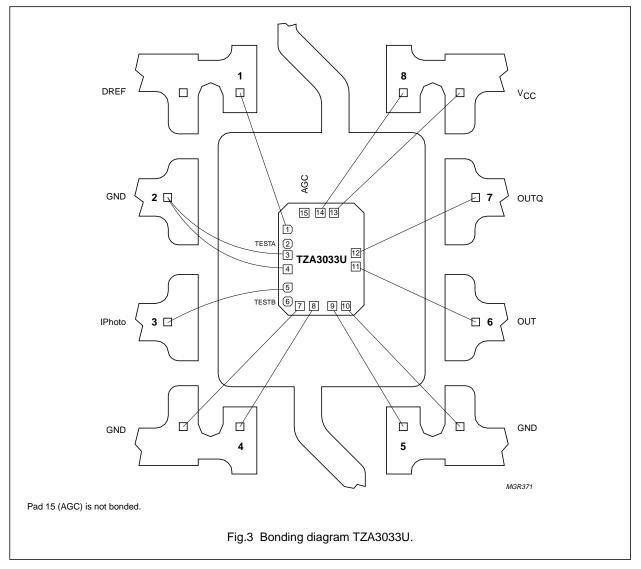
SYMBOL	PIN	TYPE	DESCRIPTION	
DREF	1	analog output	bias voltage for PIN diode (V <sub>CC</sub> ); cathode should be connected to this pin	
GND	2	ground	ground	
IPhoto	3	analog input	current input; anode of PIN diode should be connected to this pin; DC bias voltage is 1048 mV	
GND	4	ground	ground	
GND	5	ground	ground	
OUT	6	data output	data output; OUT goes HIGH when current flows into IPhoto (pin 3)	
OUTQ	7	data output	compliment of OUT (pin 6)	
V <sub>CC</sub>	8	supply	supply voltage	



### TZA3033

### PAD CONFIGURATION

#### **Bonding pad locations**



### TZA3033

#### Pad centre locations

SYMBOL	DAD	COORDINATES <sup>(1)</sup>		
STMBOL	PAD	x	у	
DREF	1	95	881	
TESTA	2	95	735	
GND	3	95	618	
GND	4	95	473	
IPhoto	5	95	285	
TESTB	6	95	147	
GND	7	215	95	
GND	8	360	95	
GND	9	549	95	
GND	10	691	95	
OUT	11	785	501	
OUTQ	12	785	641	
V <sub>CC</sub>	13	567	1055	
V <sub>CC</sub>	14	424	1055	
AGC	15	259	1055	

#### Note

 All coordinates (μm) are measured with respect to the bottom left-hand corner of the die.

#### FUNCTIONAL DESCRIPTION

The TZA3033 is a transimpedance amplifier intended for use in fibre optic links for signal recovery in STM1/OC3 applications. It amplifies the current generated by a photo detector (PIN diode or avalanche photodiode) and transforms it into a differential output voltage. The most important characteristics of the TZA3033 are high receiver sensitivity and wide dynamic range.

High receiver sensitivity is achieved by minimizing noise in the transimpedance amplifier.

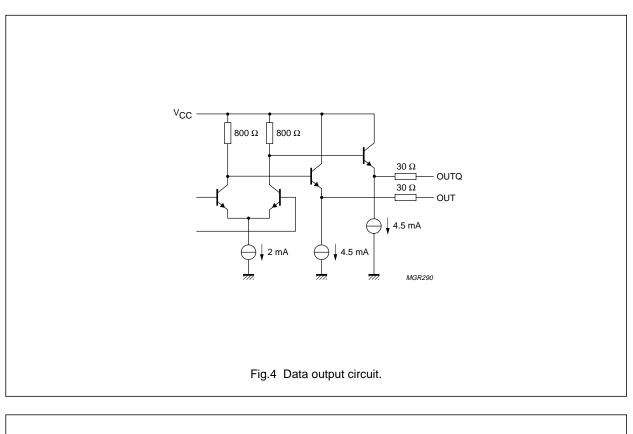
The signal current generated by a PIN diode can vary between  $0.25 \,\mu$ A to  $1.6 \,\mu$ A (peak-to-peak value). An AGC loop (see Fig.1) is implemented to make it possible to handle such a wide dynamic range. The AGC loop increases the dynamic range of the receiver by reducing the feedback resistance of the preamplifier. The AGC loop hold capacitor is integrated on-chip, so an external capacitor is not needed for AGC.

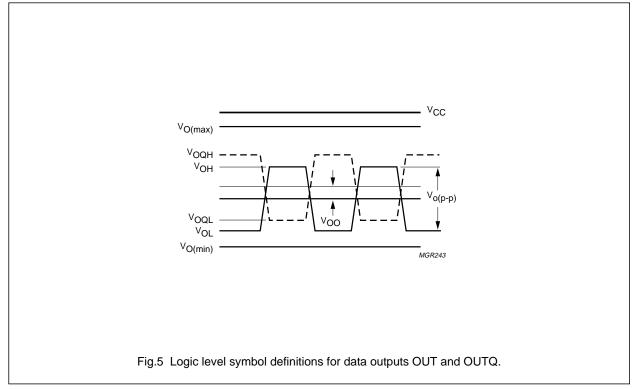
The AGC voltage can be monitored at pad 15 on the naked die (TZA3033U). Pad 15 is not bonded in the packaged device (TZA3033T). This pad can be left unconnected during normal operation. It can also be used to force an external AGC voltage. If pad 15 (AGC) is connected to  $V_{CC}$ , the internal AGC loop is disabled and the receiver gain is at a maximum. The maximum input current is then about 10  $\mu$ A.

A differential amplifier converts the output of the preamplifier to a differential voltage. The data output circuit is given in Fig.4.

The logic level symbol definitions are shown in Fig.5.

### TZA3033





TZA3033

### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER		MAX.	UNIT
V <sub>CC</sub>	supply voltage	-0.5	+5.5	V
V <sub>n</sub>	DC voltage			
	pin 3/pad 5: IPhoto	-0.5	+2	V
	pins 6 and 7/pads 11 and 12: OUT and OUTQ	-0.5	V <sub>CC</sub> + 0.5	V
	pad 15: AGC (TZA3033U only)	-0.5	V <sub>CC</sub> + 0.5	V
	pin 1/pad 1: DREF	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>n</sub>	DC current			
	pin 3/pad 5: IPhoto	-1	+2.5	mA
	pins 6 and 7/pads 11 and 12: OUT and OUTQ	–15	+15	mA
	pad 15: AGC (TZA3033U only)	-0.2	+0.2	mA
	pin 1/pad 1: DREF	-2.5	+2.5	mA
P <sub>tot</sub>	total power dissipation	-	300	mW
T <sub>stg</sub>	storage temperature		+150	°C
Tj	junction temperature	-	150	°C
T <sub>amb</sub>	ambient temperature	-40	+85	°C

### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R <sub>th(j-s)</sub>	thermal resistance from junction to solder point	tbf	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	tbf	K/W

### CHARACTERISTICS

For typical values  $T_{amb} = 25 \text{ °C}$  and  $V_{CC} = 5 \text{ V}$ ; minimum and maximum values are valid over the entire ambient temperature range and process spread.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>CC</sub>	supply voltage		3	5	5.5	V
I <sub>CC</sub>	supply current	AC coupled; $R_L = 50 \Omega$	-	37	-	mA
P <sub>tot</sub>	total power dissipation	$V_{CC} = 5 V$	-	185	-	mW
		V <sub>CC</sub> = 3.3 V	-	116	-	mW
Tj	junction temperature		-40	-	+120	°C
T <sub>amb</sub>	ambient temperature		-40	+25	+85	°C
R <sub>tr</sub>	small-signal transresistance of the	measured differentially; AC coupled				
	receiver	$R_L = \infty$	-	234	-	kΩ
		$R_L = 50 \Omega$	-	117	-	kΩ
f <sub>-3dB(h)</sub>	high frequency –3 dB point	C <sub>i</sub> = 0.7 pF	120	150	-	MHz

### TZA3033

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>n(tot)</sub>	total integrated RMS	referred to input; note 1				
	noise current over	∆f = 90 MHz	_	16	-	nA
	bandwidth	∆f = 120 MHz	_	tbf	-	nA
		∆f = 150MHz	_	tbf	-	nA
$\Delta R_{tr} / \Delta t$	AGC loop constant		-	1	-	dB/ms
PSRR	power supply rejection ratio	measured differentially; note 2				
		f = 100 kHz to 10 MHz	_	0.5	-	μA/V
		f = 100 MHz	_	10	-	μA/V
Input: IPho	to	•			•	
I <sub>i(IPhoto)(p-p)</sub>	input current on	V <sub>CC</sub> = 5 V	-500	+1	+1800	μA
	pin IPhoto (peak-to-peak value)	V <sub>CC</sub> = 3.3 V	-500	+1	+1600	μA
V <sub>bias</sub> (IPhoto)	input bias voltage on pin IPhoto		-	1048	-	mV
Data outpu	ts: OUT and OUTQ	•	•		•	
V <sub>O(CM)</sub>	common mode output voltage	AC coupled; $R_L = 50 \Omega$	V <sub>CC</sub> – 1.800	V <sub>CC</sub> – 1.700	V <sub>CC</sub> – 1.600	V
V <sub>o(se)(p-p)</sub>	single-ended output voltage (peak-to-peak value)	AC coupled; $R_L = 50 \Omega$	-	150	260	mV
V <sub>OO</sub>	differential output offset voltage		-100	-	+100	mV
Ro	output resistance	single-ended; DC tested	42	50	58	Ω
t <sub>r</sub>	rise time	20% to 80%	-	tbf	-	ps
t <sub>f</sub>	fall time	80% to 20%	-	tbf	-	ps

#### Notes

1. All  $I_{n(tot)}$  measurements were made with an input capacitance of  $C_i = 1 \text{ pF}$ . This was comprised of 0.5 pF for the photodiode itself, with 0.3 pF allowed for the printed-circuit board layout and 0.2 pF intrinsic to the package.

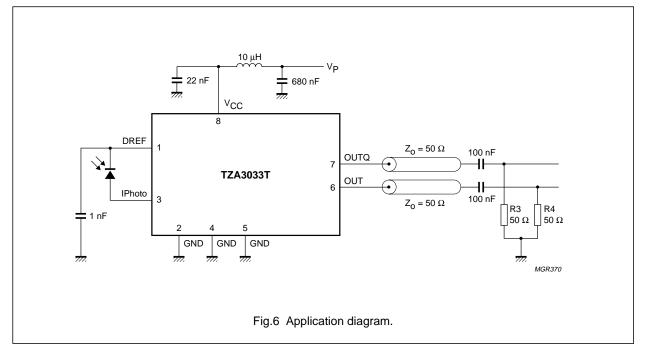
2. PSRR is defined as the ratio of the equivalent current change at the input ( $\Delta I_{IPhoto}$ ) to a change in supply voltage:

$$\mathsf{PSRR} = \frac{\Delta \mathsf{I}_{\mathsf{IPhoto}}}{\Delta \mathsf{V}_{\mathsf{CC}}}$$

For example, a disturbance of +4 mV disturbance on  $V_{CC}$  at 10 MHz will typically add an extra 2 nA to the photodiode current. The external capacitor between DREF and GND has a large impact on PSRR. The specification is valid with an external capacitor of 1 nF.

### TZA3033

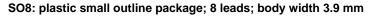
### **APPLICATION INFORMATION**

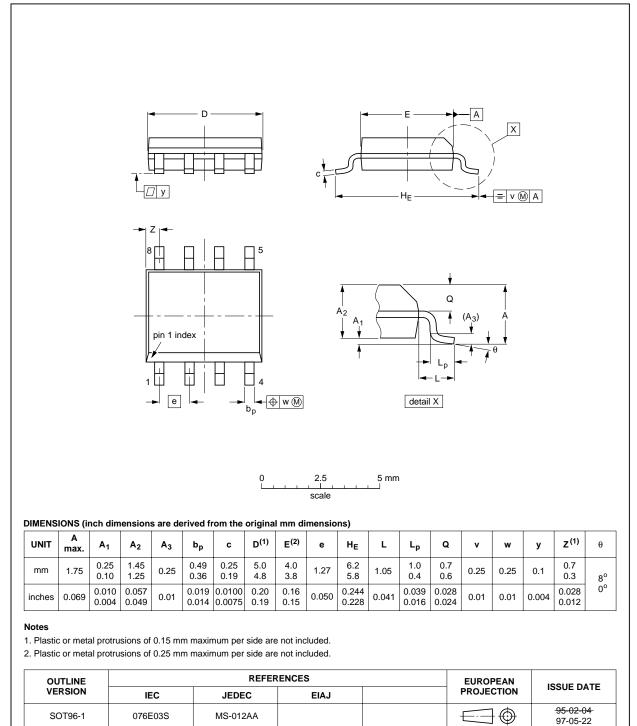


TZA3033

### SDH/SONET STM1/OC3 transimpedance amplifier

#### PACKAGE OUTLINE





1998 Jul 08

SOT96-1

### TZA3033

#### SOLDERING

#### Introduction

There is no soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and surface mounted components are mixed on one printed-circuit board. However, wave soldering is not always suitable for surface mounted ICs, or for printed-circuits with high population densities. In these situations reflow soldering is often used.

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our "*Data Handbook IC26; Integrated Circuit Packages*" (order code 9398 652 90011).

#### **Reflow soldering**

Reflow soldering techniques are suitable for all SO packages.

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several techniques exist for reflowing; for example, thermal conduction by heated belt. Dwell times vary between 50 and 300 seconds depending on heating method. Typical reflow temperatures range from 215 to 250 °C.

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 minutes at 45 °C.

#### Wave soldering

Wave soldering techniques can be used for all SO packages if the following conditions are observed:

- A double-wave (a turbulent wave with high upward pressure followed by a smooth laminar wave) soldering technique should be used.
- The longitudinal axis of the package footprint must be parallel to the solder flow.
- The package footprint must incorporate solder thieves at the downstream end.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Maximum permissible solder temperature is 260 °C, and maximum duration of package immersion in solder is 10 seconds, if cooled to less than 150 °C within 6 seconds. Typical dwell time is 4 seconds at 250 °C.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

#### **Repairing soldered joints**

Fix the component by first soldering two diagonallyopposite end leads. Use only a low voltage soldering iron (less than 24 V) applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C. When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

### TZA3033

#### DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
more of the limiting values of the device at these or at	accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or may cause permanent damage to the device. These are stress ratings only and operation any other conditions above those given in the Characteristics sections of the specification limiting values for extended periods may affect device reliability.
Application information	
	ion in situan it is advisent, and does not form part of the analitication

Where application information is given, it is advisory and does not form part of the specification.

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Argentina: see South America Australia: 34 Waterloo Road, NORTH RYDE, NSW 2113, Tel. +61 2 9805 4455, Fax. +61 2 9805 4466 Austria: Computerstr. 6, A-1101 WIEN, P.O. Box 213, Tel. +43 160 1010, Fax. +43 160 101 1210 Belarus: Hotel Minsk Business Center, Bld. 3, r. 1211, Volodarski Str. 6, 220050 MINSK, Tel. +375 172 200 733, Fax. +375 172 200 773 Belgium: see The Netherlands Brazil: see South America Bulgaria: Philips Bulgaria Ltd., Energoproject, 15th floor, 51 James Bourchier Blvd., 1407 SOFIA Tel. +359 2 689 211, Fax. +359 2 689 102 Canada: PHILIPS SEMICONDUCTORS/COMPONENTS, Tel. +1 800 234 7381 China/Hong Kong: 501 Hong Kong Industrial Technology Centre, 72 Tat Chee Avenue, Kowloon Tong, HONG KONG, Tel. +852 2319 7888, Fax. +852 2319 7700 Colombia: see South America Czech Republic: see Austria Denmark: Prags Boulevard 80, PB 1919, DK-2300 COPENHAGEN S, Tel. +45 32 88 2636, Fax. +45 31 57 0044 Finland: Sinikalliontie 3, FIN-02630 ESPOO, Tel. +358 9 615800, Fax. +358 9 61580920 France: 51 Rue Carnot. BP317. 92156 SURESNES Cedex. Tel. +33 1 40 99 6161, Fax. +33 1 40 99 6427 Germany: Hammerbrookstraße 69, D-20097 HAMBURG, Tel. +49 40 23 53 60, Fax. +49 40 23 536 300 Greece: No. 15, 25th March Street, GR 17778 TAVROS/ATHENS, Tel. +30 1 4894 339/239, Fax. +30 1 4814 240 Hungary: see Austria India: Philips INDIA Ltd, Band Box Building, 2nd floor, 254-D. Dr. Annie Besant Road, Worli, MUMBAI 400 025. Tel. +91 22 493 8541, Fax. +91 22 493 0966 Indonesia: PT Philips Development Corporation, Semiconductors Division, Gedung Philips, Jl. Buncit Raya Kav.99-100, JAKARTA 12510, Tel. +62 21 794 0040 ext. 2501, Fax. +62 21 794 0080 Ireland: Newstead, Clonskeagh, DUBLIN 14, Tel. +353 1 7640 000, Fax. +353 1 7640 200 Israel: RAPAC Electronics, 7 Kehilat Saloniki St, PO Box 18053, TEL AVIV 61180, Tel. +972 3 645 0444, Fax. +972 3 649 1007 Italy: PHILIPS SEMICONDUCTORS, Piazza IV Novembre 3, 20124 MILANO, Tel. +39 2 6752 2531, Fax. +39 2 6752 2557 Japan: Philips Bldg 13-37, Kohnan 2-chome, Minato-ku, TOKYO 108-8507, Tel. +81 3 3740 5130, Fax. +81 3 3740 5077 Korea: Philips House, 260-199 Itaewon-dong, Yongsan-ku, SEOUL, Tel. +82 2 709 1412, Fax. +82 2 709 1415 Malaysia: No. 76 Jalan Universiti, 46200 PETALING JAYA, SELANGOR, Tel. +60 3 750 5214, Fax. +60 3 757 4880

Mexico: 5900 Gateway East, Suite 200, EL PASO, TEXAS 79905, Tel. +9-5 800 234 7381

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Portugal: see Spain

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Russia: Philips Russia, UI. Usatcheva 35A, 119048 MOSCOW, Tel. +7 095 755 6918, Fax. +7 095 755 6919

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South America: Al. Vicente Pinzon, 173, 6th floor, 04547-130 SÃO PAULO, SP, Brazil,

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Tel. +34 93 301 6312, Fax. +34 93 301 4107

Sweden: Kottbygatan 7, Akalla, S-16485 STOCKHOLM, Tel. +46 8 5985 2000, Fax. +46 8 5985 2745

**Switzerland:** Allmendstrasse 140, CH-8027 ZÜRICH, Tel. +41 1 488 2741 Fax. +41 1 488 3263

Taiwan: Philips Semiconductors, 6F, No. 96, Chien Kuo N. Rd., Sec. 1, TAIPEI, Taiwan Tel. +886 2 2134 2865, Fax. +886 2 2134 2874

Thailand: PHILIPS ELECTRONICS (THAILAND) Ltd., 209/2 Sanpavuth-Bangna Road Prakanong, BANGKOK 10260, Tel. +66 2 745 4090, Fax. +66 2 398 0793

Turkey: Talatpasa Cad. No. 5, 80640 GÜLTEPE/ISTANBUL, Tel. +90 212 279 2770, Fax. +90 212 282 6707

Ukraine: PHILIPS UKRAINE, 4 Patrice Lumumba str., Building B, Floor 7, 252042 KIEV, Tel. +380 44 264 2776, Fax. +380 44 268 0461

United Kingdom: Philips Semiconductors Ltd., 276 Bath Road, Hayes, MIDDLESEX UB3 5BX, Tel. +44 181 730 5000, Fax. +44 181 754 8421 United States: 811 East Arques Avenue, SUNNYVALE, CA 94088-3409, Tel. +1 800 234 7381

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